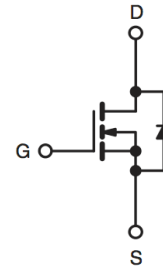


GENERAL DESCRIPTION

This Power MOSFET is produced using the advanced planar stripe, DMOS technology. This latest technology has been especially designed to minimize on-state resistance, have high rugged avalanche characteristics. These devices are well suited for high efficiency switch mode power supplies, active power factor correction, and electronic lamp ballasts based on half bridge topology.

FEATURES

- RDS(on) (typ 1.3 Ω) @ VGS=10V
- Gate Charge (Typical 39nC)
- Improved dv/dt Capability, High Ruggedness
- 100% Avalanche Tested
- Maximum Junction Temperature Range (150°C)
- Halogen Free



RoHS
COMPLIANT

HALOGEN
FREE
Available

Absolute Maximum Ratings (T_c=25°C unless otherwise specified)

Symbol	Parameter	Value	Unit
V _{DSS}	Drain-Source Voltage	800	V
I _D	Drain Current -Continuous (T _C =25°C)	8	A
	Drain Current -Continuous (T _C =100°C)	5.0	A
I _{DM}	Drain Current -Pulsed	32	A
V _{GS}	Gate-Source Voltage	±30	V
E _{AS}	Single Pulsed Avalanche Energy	850	mJ
E _{AR}	Repetitive Avalanche Energy	17.8	mJ
d _v /d _t	Peak Diode Recovery dv/dt	4.5	V/ns
P _D	Power Dissipation (T _C =25°C) - Derate above 25°C	59	W
		0.48	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range	-55 to + 150	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	°C

- Drain current limited by maximum junction temperature

Thermal Resistance Characteristics

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	2.1	°C/W
$R_{\theta JA}$	Junction-to-Ambient	—	62.5	

Electrical Characteristics (Tc=25°C unless otherwise specified)

Symbol	Parameter	Test Conditions	Min	Type	Max	Units
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On Characteristics

V_{GS}	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	3.0	--	5.0	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS}=10V, I_D=4.0A$	—	1.3	1.6	Ω

Off Characteristics

BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	800	—	—	V
$\Delta BV_{DSS} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D=250\mu A$, Referenced to 25°C	—	0.6	—	V/°C
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=800V, V_{GS}=0V$	—	—	10	μA
		$V_{DS}=640V, V_C=125^\circ C$	—	—	100	μA
I_{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS}=30V, V_{DS}=0V$	—	—	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS}=-30V, V_{DS}=0V$	—	—	-100	nA

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{DS}=25V, V_{GS}=0V,$ $f=1.0MHz$	—	1700	—	pF
C_{oss}	Output Capacitance		—	140	—	pF
C_{rss}	Reverse Transfer Capacitance		—	15	—	pF

Switching Characteristics

$t_{d(on)}$	Turn-On Time	$V_{DS}=400V, I_D=8.0A,$ $R_G=25\Omega$	—	50	--	ns
t_r	Turn-On Rise Time		—	100	--	ns
$t_{d(off)}$	Turn-Off Delay Time		—	70	--	ns
t_f	Turn-Off Fall Time		—	70	--	ns
Q_g	Total Gate Charge	$V_{DS}=640V, I_D=8.0A,$ $V_{GS}=10V$	—	37	--	nC
Q_{gs}	Gate-Source Charge		—	11	—	nC
Q_{gd}	Gate-Drain Charge		—	15	—	nC



MSF8N80-G 800V N-Channel MOSFET

Source-Drain Diode Maximum Ratings and Characteristics

I_S	Continuous Source-Drain Diode Forward Current	—	—	8.0	A	
I_{SM}	Pulsed Source-Drain Diode Forward Current	—	—	32.0		
V_{SD}	Source-Drain Diode Forward Voltage	$I_S=8A, V_{GS}=0V$	—	—	1.4	V
trr	Reverse Recovery Time	$I_S=8 A, V_{GS}= 0V$	—	0.7	—	us
Qrr	Reverse Recovery Charge	$di_F/dt=100A/\mu s$	—	8.0	—	μC

Notes:

1. Repeativity rating : pulse width limited by junction temperature
2. L = 25.0mH, IAS =8.0A, VDD = 50V, RG = 25 Ω , Starting TJ = 25°C
3. ISD \leq 8.0A, di/dt \leq 200A/us, VDD \leq BVDSS, Starting TJ = 25°C
4. Pulse Test : Pulse Width \leq 300us, Duty Cycle \leq 2%
5. Essentially independent of operating temperature.

• Characteristic Curves

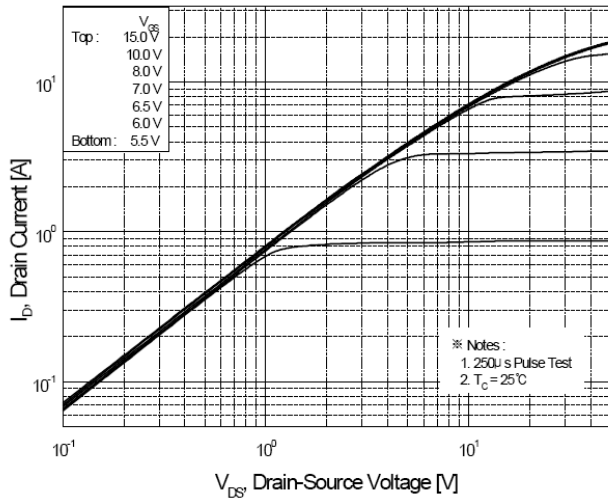


Figure 1. On Region Characteristics

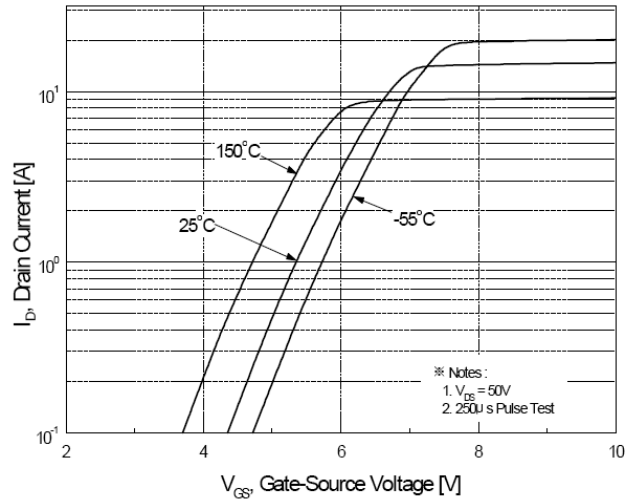


Figure 2. Transfer Characteristics

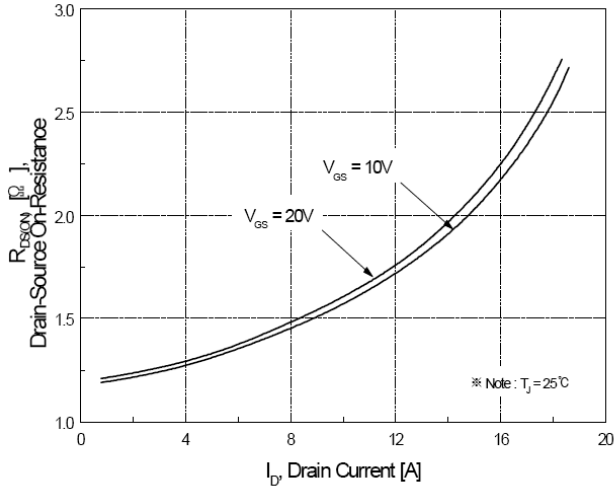


Figure 3. On Resistance Variation vs Drain Current and Gate Voltage

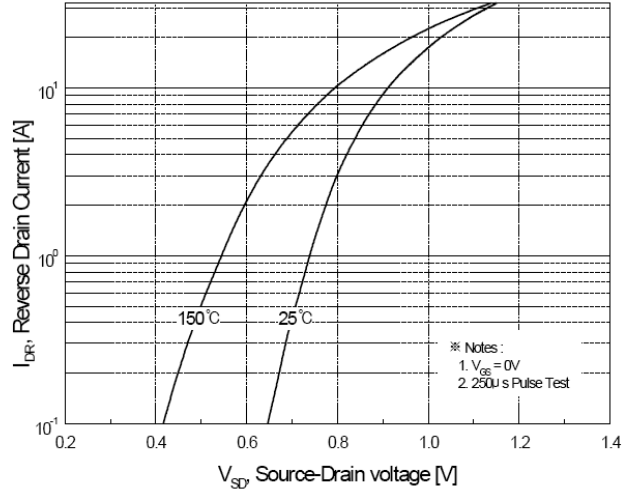


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

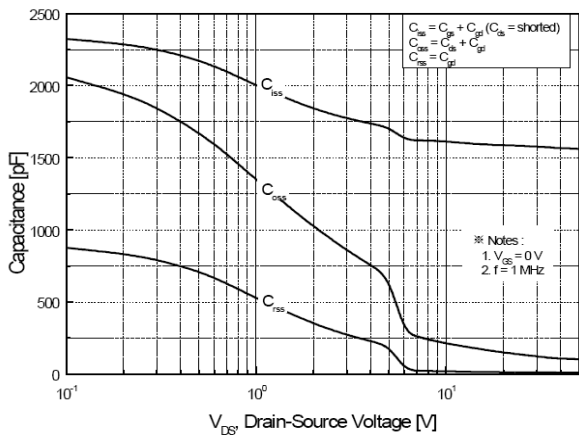


Figure 5. Capacitance Characteristics

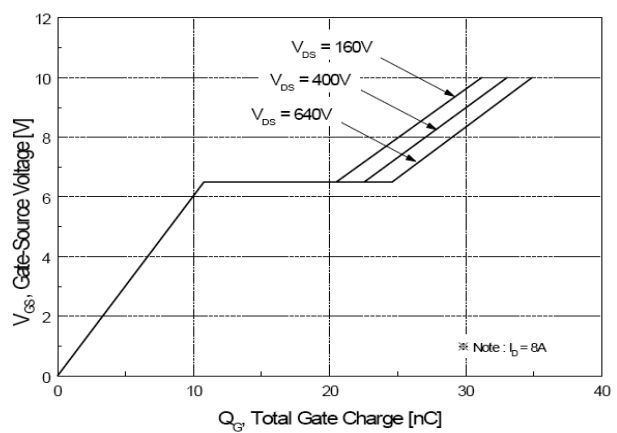


Figure 6. Gate Charge Characteristics

• Characteristic Curves

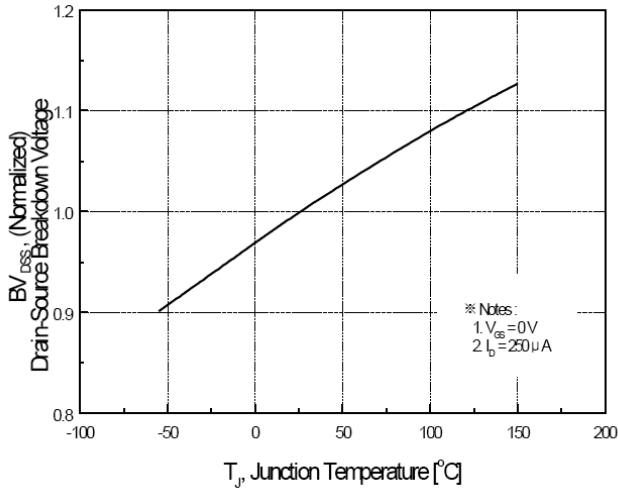


Figure 7. Breakdown Voltage Variation vs Temperature

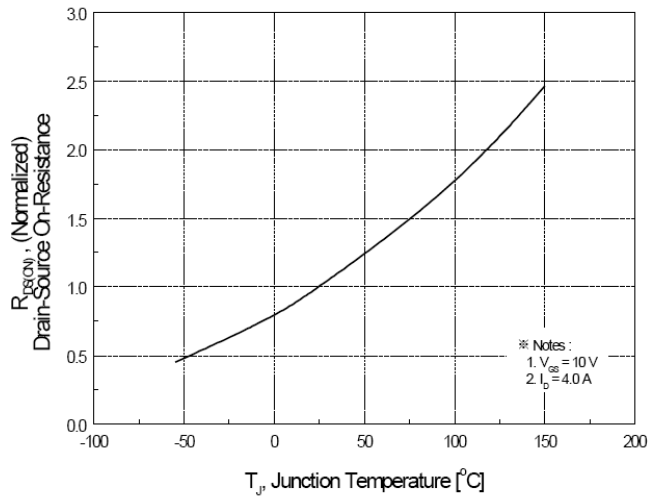


Figure 8. On-Resistance Variation vs Temperature

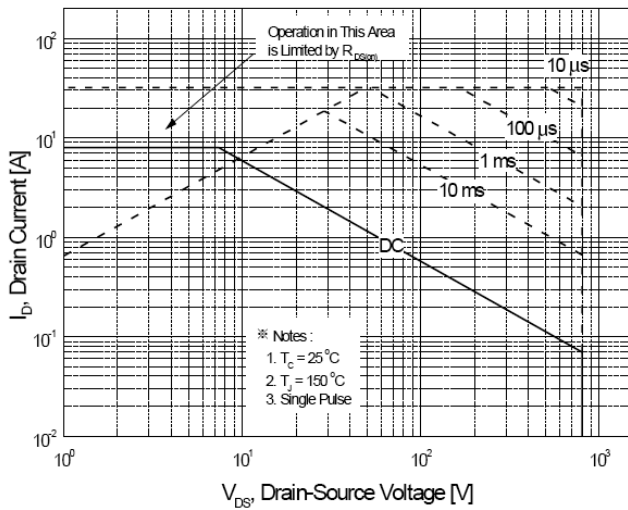


Figure 9. Maximum Safe Operating Area

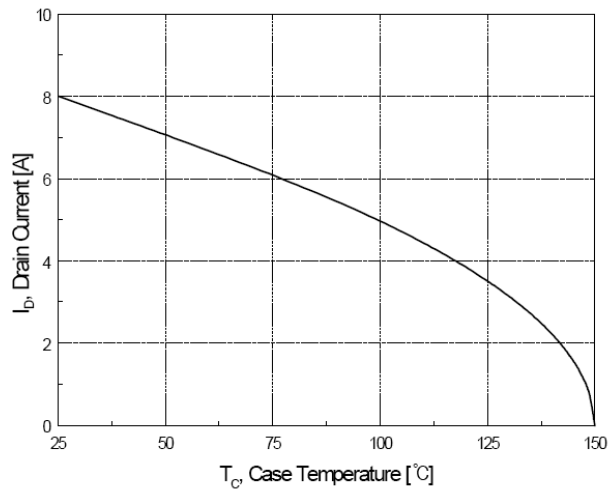


Figure 10. Maximum Drain Current vs Case Temperature

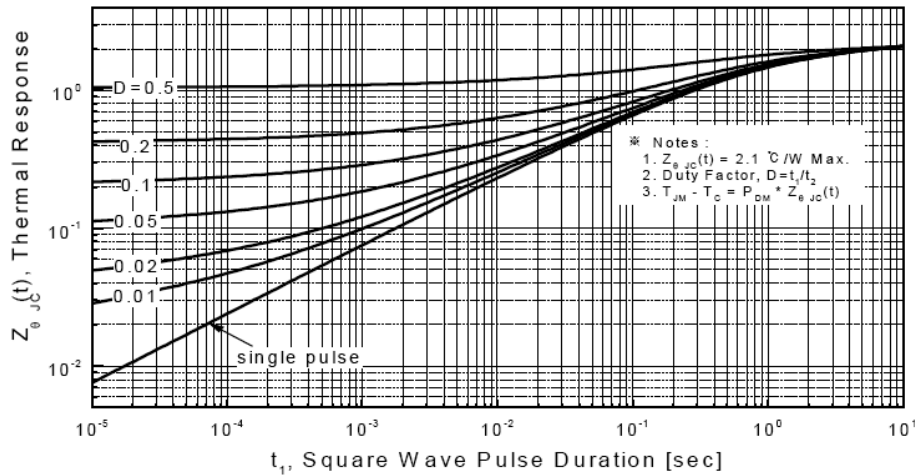


Figure 11. Transient Thermal Response Curve

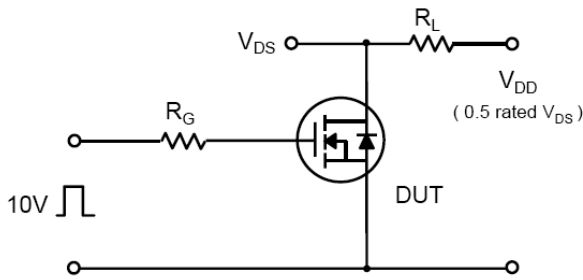


Fig 12. Resistive Switching Test Circuit & Waveforms

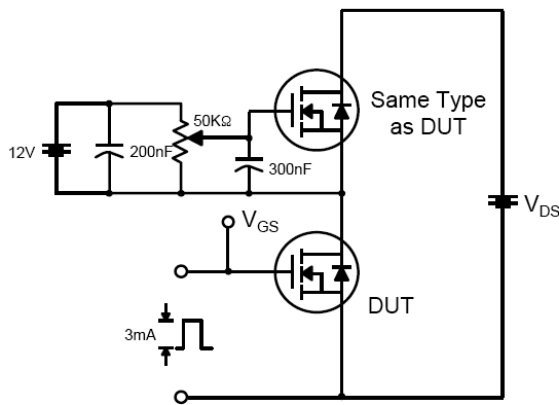


Fig 13. Gate Charge Test Circuit & Waveform

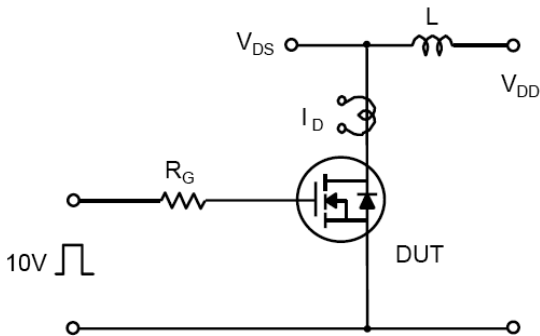


Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms

$$E_{AS} = \frac{1}{2} L_L I_{AS}^2 \frac{BV_{DSS}}{BV_{DSS} - V_{DD}}$$

The waveform shows $I_D(t)$ as a triangular pulse and $V_{DS}(t)$ as a trapezoidal pulse. The peak current is I_{AS} and the peak voltage is BV_{DSS} . The pulse width is t_p .

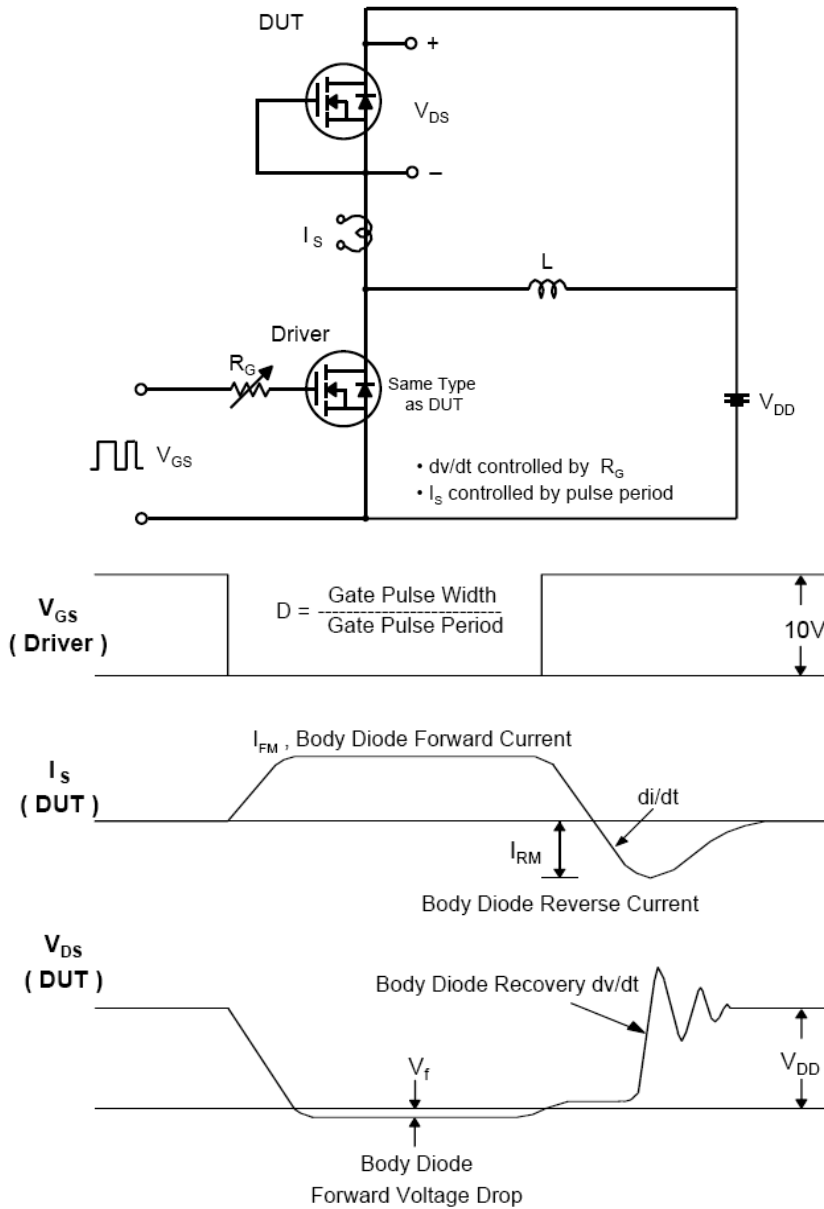
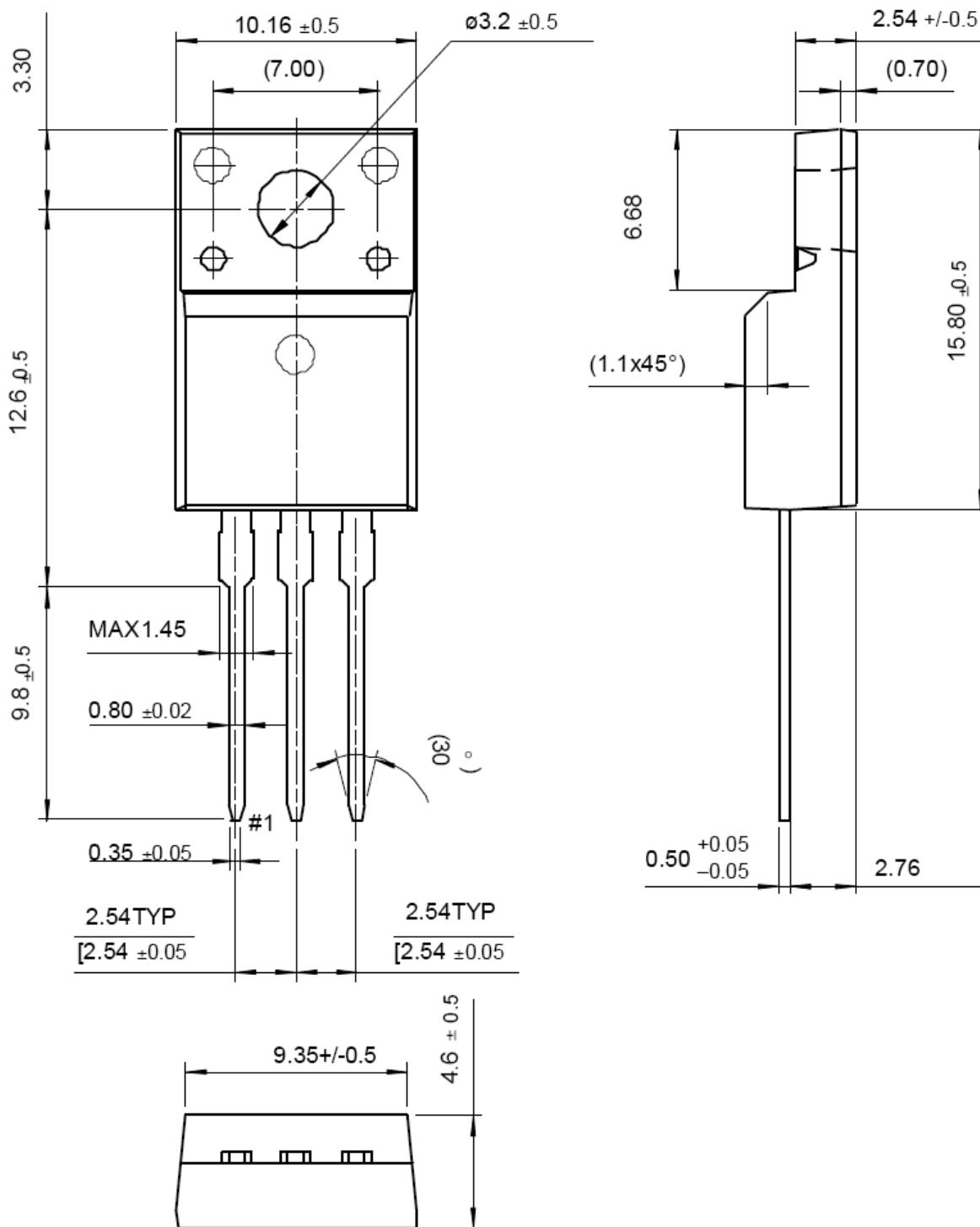


Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

Package Dimensions

Dimensions in Millimeters





MSF8N80-G 800V N-Channel MOSFET

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